Search Notes			

Application No.	Applicant(s)	
09/391,606	MURDIN ET AL.	
Examiner	Art Unit	
Shin-Lin Chen	1632	

SEARCHED			
Class	Subclass	Date	Examiner
424	185.1, 190.1		
530	350		
536	23.7	6/7/2004	SW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
424	190.1		
424	185.1		
530	350		
536/23.7; Intereference search for SEQ ID Nos. 1-4,7-9,12-16		6/7/2004	m

SEARCH NOT (INCLUDING SEARCH		
	DATE	EXMR
Updated, sequence search for issued patent database	6/7/2004	416
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